

RF Power LDMOS Transistors

High Ruggedness N-Channel Enhancement-Mode Lateral MOSFETs

These high ruggedness devices are designed for use in high VSWR industrial, scientific and medical applications, as well as radio and VHF TV broadcast, sub-GHz aerospace and mobile radio applications. Their unmatched input and output design allows for wide frequency range use from 1.8 to 500 MHz.

Typical Performance: $V_{DD} = 50$ Vdc

Frequency (MHz)	Signal Type	P_{out} (W)	G_{ps} (dB)	η_D (%)
87.5–108 (1,2)	CW	1421 CW	23.1	83.2
230 (3,4)	Pulse (100 μ sec, 20% Duty Cycle)	1500 Peak	23.4	75.1

Load Mismatch/Ruggedness

Frequency (MHz)	Signal Type	VSWR	P_{in} (W)	Test Voltage	Result
230 (3)	Pulse (100 μ sec, 20% Duty Cycle)	> 65:1 at all Phase Angles	15 Peak (3 dB Overdrive)	50	No Device Degradation

1. Data from 87.5–108 MHz broadband reference circuit (page 5).
2. The values shown are the center band performance numbers across the indicated frequency range.
3. Data from 230 MHz narrowband production test fixture (page 11).
4. All data measured in fixture with device soldered to heatsink.

Features

- High drain-source avalanche energy absorption capability
- Unmatched input and output allowing wide frequency range utilization
- Device can be used single-ended or in a push-pull configuration
- Characterized from 30 to 50 V for ease of use
- Suitable for linear application
- Integrated ESD protection with greater negative gate-source voltage range for improved Class C operation
- Recommended driver: MRFE6VS25N (25 W)

Typical Applications

- Industrial, Scientific, Medical (ISM)
 - Laser generation
 - Plasma etching
 - Particle accelerators
 - MRI and other medical applications
 - Industrial heating, welding and drying systems
- Broadcast
 - Radio broadcast
 - VHF TV broadcast
- Aerospace
 - VHF omnidirectional range (VOR)
 - HF and VHF communications
 - Weather radar
- Mobile Radio
 - VHF and UHF base stations

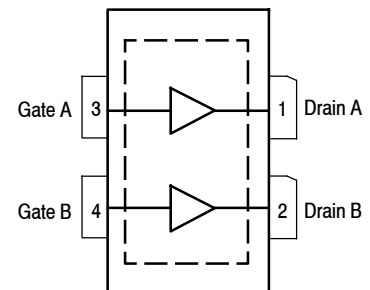
MRF1K50N
MRF1K50GN

1.8–500 MHz, 1500 W CW, 50 V
WIDEBAND
RF POWER LDMOS TRANSISTORS

OM-1230-4L
PLASTIC
MRF1K50N



OM-1230G-4L
PLASTIC
MRF1K50GN



(Top View)

Note: Exposed backside of the package is the source terminal for the transistor.

Figure 1. Pin Connections

Table 1. Maximum Ratings

Rating	Symbol	Value	Unit
Drain-Source Voltage	V_{DSS}	-0.5, +133	Vdc
Gate-Source Voltage	V_{GS}	-6.0, +10	Vdc
Operating Voltage	V_{DD}	50	Vdc
Storage Temperature Range	T_{stg}	-65 to +150	°C
Case Operating Temperature Range	T_C	-40 to +150	°C
Operating Junction Temperature Range (1,2)	T_J	-40 to +225	°C
Total Device Dissipation @ $T_C = 25^\circ\text{C}$ Derate above 25°C	P_D	2941 14.71	W W/°C

Table 2. Thermal Characteristics

Characteristic	Symbol	Value (2,3)	Unit
Thermal Resistance, Junction to Case CW: Case Temperature 80°C, 1500 W CW, 50 Vdc, $I_{DQ(A+B)} = 200$ mA, 98 MHz	$R_{\theta JC}$	0.068	°C/W
Thermal Impedance, Junction to Case Pulse: Case Temperature 75°C, 1500 W Peak, 100 μsec Pulse Width, 20% Duty Cycle, 50 Vdc, $I_{DQ(A+B)} = 100$ mA, 230 MHz	$Z_{\theta JC}$	0.015	°C/W

Table 3. ESD Protection Characteristics

Test Methodology	Class
Human Body Model (per JESD22-A114)	2, passes 2500 V
Charge Device Model (per JESD22-C101)	C3, passes 2000 V

Table 4. Moisture Sensitivity Level

Test Methodology	Rating	Package Peak Temperature	Unit
Per JESD22-A113, IPC/JEDEC J-STD-020	3	260	°C

Table 5. Electrical Characteristics ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
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Off Characteristics (4)

Gate-Source Leakage Current ($V_{GS} = 5$ Vdc, $V_{DS} = 0$ Vdc)	I_{GSS}	—	—	1	μAdc
Drain-Source Breakdown Voltage ($V_{GS} = 0$ Vdc, $I_D = 100$ mAdc)	$V_{(BR)DSS}$	133	—	—	Vdc
Zero Gate Voltage Drain Leakage Current ($V_{DS} = 50$ Vdc, $V_{GS} = 0$ Vdc)	I_{DSS}	—	—	10	μAdc
Zero Gate Voltage Drain Leakage Current ($V_{DS} = 133$ Vdc, $V_{GS} = 0$ Vdc)	I_{DSS}	—	—	100	mAdc

On Characteristics

Gate Threshold Voltage (4) ($V_{DS} = 10$ Vdc, $I_D = 2130$ μAdc)	$V_{GS(th)}$	1.7	2.2	2.7	Vdc
Gate Quiescent Voltage ($V_{DD} = 50$ Vdc, $I_{D(A+B)} = 100$ mAdc, Measured in Functional Test)	$V_{GS(Q)}$	1.9	2.4	2.9	Vdc
Drain-Source On-Voltage (4) ($V_{GS} = 10$ Vdc, $I_D = 2.4$ Adc)	$V_{DS(on)}$	—	0.15	—	Vdc
Forward Transconductance (4) ($V_{DS} = 10$ Vdc, $I_D = 36$ Adc)	g_{fs}	—	33.5	—	S

1. Continuous use at maximum temperature will affect MTTF.
2. MTTF calculator available at <http://www.nxp.com/RF/calculators>.
3. Refer to AN1955, *Thermal Measurement Methodology of RF Power Amplifiers*. Go to <http://www.nxp.com/RF> and search for AN1955.
4. Each side of device measured separately.

(continued)

Table 5. Electrical Characteristics ($T_A = 25^\circ\text{C}$ unless otherwise noted) (continued)

Characteristic	Symbol	Min	Typ	Max	Unit
Dynamic Characteristics ⁽¹⁾					
Reverse Transfer Capacitance ($V_{DS} = 50\text{ Vdc} \pm 30\text{ mV(rms)ac}$ @ 1 MHz, $V_{GS} = 0\text{ Vdc}$)	C_{rss}	—	5.77	—	pF
Output Capacitance ($V_{DS} = 50\text{ Vdc} \pm 30\text{ mV(rms)ac}$ @ 1 MHz, $V_{GS} = 0\text{ Vdc}$)	C_{oss}	—	219	—	pF
Input Capacitance ($V_{DS} = 50\text{ Vdc}$, $V_{GS} = 0\text{ Vdc} \pm 30\text{ mV(rms)ac}$ @ 1 MHz)	C_{iss}	—	683	—	pF

Functional Tests ^(2,3) (In NXP Production Test Fixture, 50 ohm system) $V_{DD} = 50\text{ Vdc}$, $I_{DQ(A+B)} = 100\text{ mA}$, $P_{out} = 1500\text{ W Peak}$ (300 W Avg.), $f = 230\text{ MHz}$, 100 μsec Pulse Width, 20% Duty Cycle

Power Gain	G_{ps}	21.5	23.0	25.0	dB
Drain Efficiency	η_D	68.0	73.0	—	%
Input Return Loss	IRL	—	-16	-9	dB

Table 6. Load Mismatch/Ruggedness (In NXP Production Test Fixture, 50 ohm system) $I_{DQ(A+B)} = 100\text{ mA}$

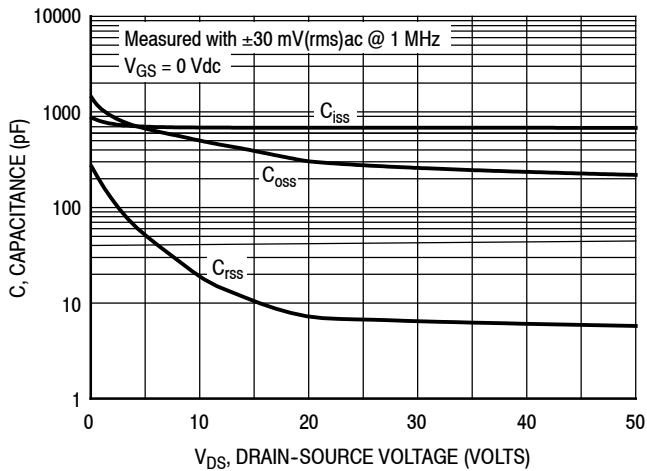
Frequency (MHz)	Signal Type	VSWR	P_{in} (W)	Test Voltage, V_{DD}	Result
230	Pulse (100 μsec , 20% Duty Cycle)	> 65:1 at all Phase Angles	15 Peak (3 dB Overdrive)	50	No Device Degradation

Table 7. Ordering Information

Device	Tape and Reel Information	Package
MRF1K50NR5	R5 Suffix = 50 Units, 56 mm Tape Width, 13-inch Reel	OM-1230-4L
MRF1K50GNR5		OM-1230G-4L

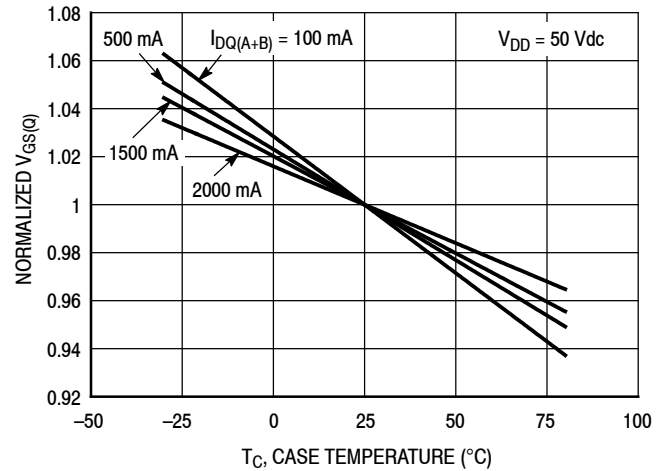
- Each side of device measured separately.
- Devices tested without thermal grease or solder under the transistor.
- Measurements made with device in straight lead configuration before any lead forming operation is applied. Lead forming is used for gull wing (GN) parts.

TYPICAL CHARACTERISTICS



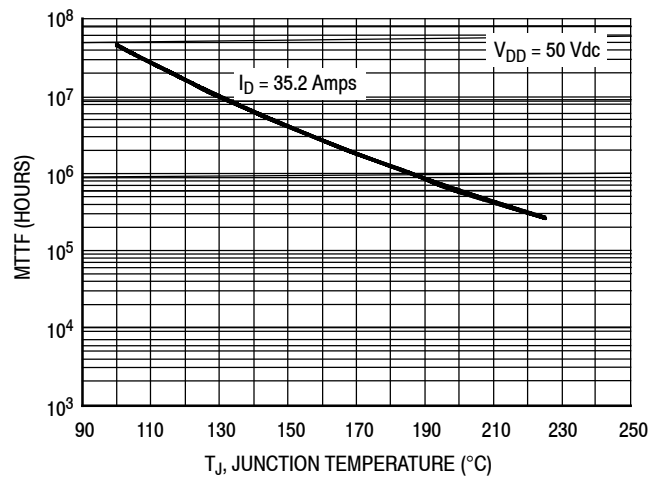
Note: Each side of device measured separately.

Figure 2. Capacitance versus Drain-Source Voltage



I_{DQ} (mA)	Slope (mV/ $^{\circ}C$)
100	-2.76
500	-2.38
1500	-2.20
2000	-1.76

Figure 3. Normalized V_{GS} versus Quiescent Current and Case Temperature



Note: MTTF value represents the total cumulative operating time under indicated test conditions.

MTTF calculator available at <http://www.nxp.com/RF/calculators>.

Figure 4. MTTF versus Junction Temperature — CW

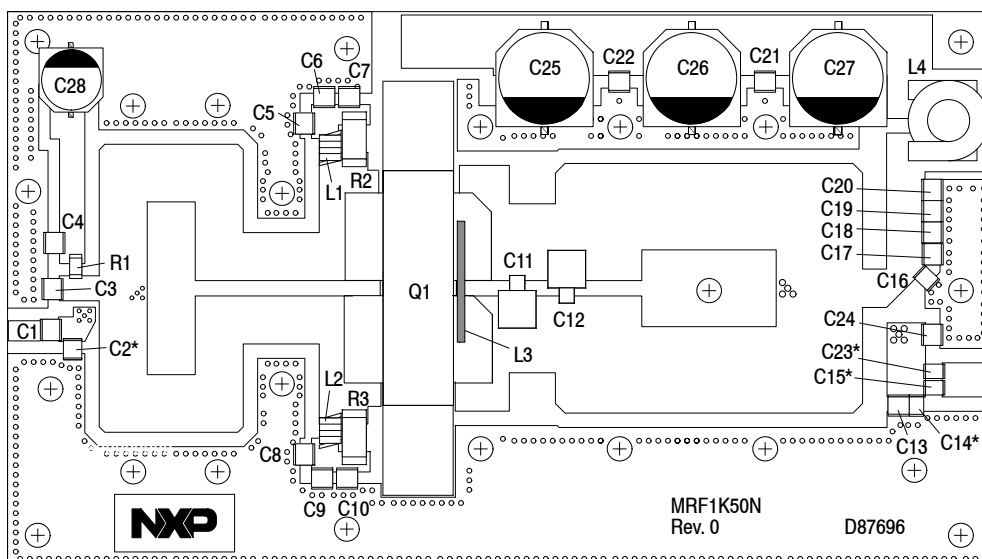
87.5–108 MHz BROADBAND REFERENCE CIRCUIT

Table 8. 87.5–108 MHz Broadband Performance (In NXP Reference Circuit, 50 ohm system)

$V_{DD} = 50$ Vdc, $I_{DQ(A+B)} = 200$ mA, $P_{in} = 7$ W, CW

Frequency (MHz)	G_{ps} (dB)	η_D (%)	P_{out} (W)
87.5	22.5	81.7	1257
98	23.1	83.2	1421
108	22.8	79.1	1328

87.5–108 MHz BROADBAND REFERENCE CIRCUIT — 2.88" × 5.12" (73 mm × 130 mm)



*C2, C14, C15 and C23 are mounted vertically.

Note: Q1 leads are soldered to the PCB with L3 soldered directly on top of the drain leads.

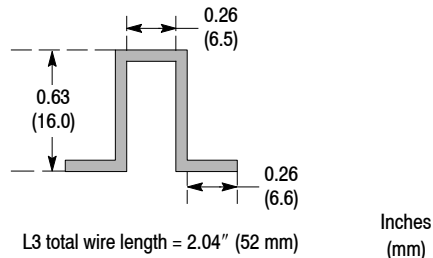


Figure 5. MRF1K50N 87.5–108 MHz Broadband Reference Circuit Component Layout

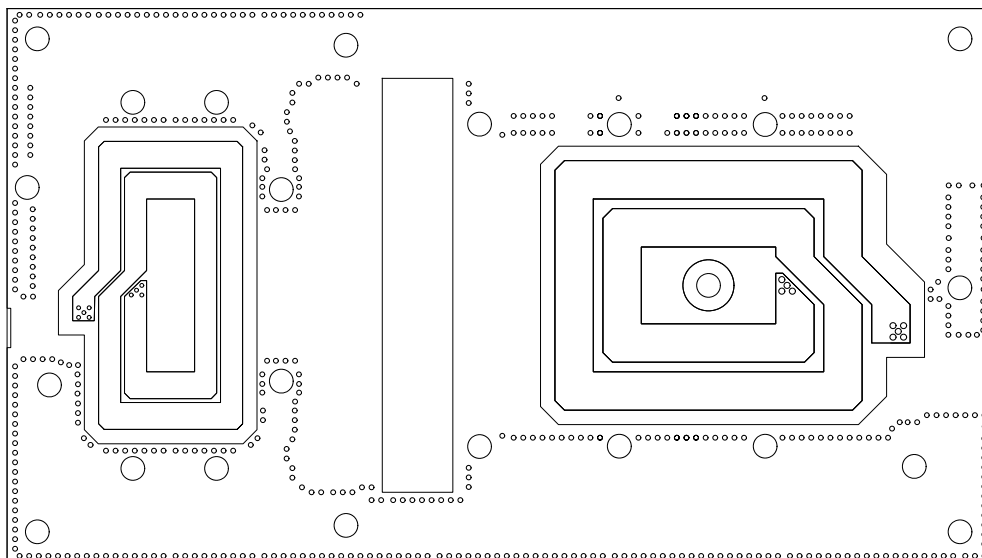


Figure 6. MRF1K50N 87.5–108 MHz Broadband Reference Circuit Component Layout — Bottom

87.5–108 MHz BROADBAND REFERENCE CIRCUIT

Table 9. MRF1K50N Broadband Reference Circuit Component Designations and Values — 87.5–108 MHz

Part	Description	Part Number	Manufacturer
C1, C3, C6, C9, C18, C19, C20, C21, C22	1000 pF Chip Capacitors	ATC100B102JT50XT	ATC
C2	33 pF Chip Capacitor	ATC100B330JT500XT	ATC
C4, C5, C8	10,000 pF Chip Capacitors	ATC200B103KT50XT	ATC
C7, C10, C15, C16, C17, C23	470 pF Chip Capacitors	ATC100B471JT200XT	ATC
C11	91 pF, 300 V Mica Capacitor	MIN02-002EC910J-F	CDE
C12	56 pF, 300 V Mica Capacitor	MIN02-002DC560J-F	CDE
C13	2.2 pF Chip Capacitor	ATC100B2R2JT500XT	ATC
C14, C24	12 pF Chip Capacitors	ATC100B120GT500XT	ATC
C25, C26, C27	220 μ F, 100 V Electrolytic Capacitors	EEV-FK1A221M	Panasonic
C28	22 μ F, 35 V Electrolytic Capacitor	UUD1V220MCL1GS	Nichicon
L1, L2	17.5 nH Inductors, 6 Turns	B06TJLC	Coilcraft
L3	1.5 mm Non-Tarnish Silver Plated Copper Wire	SP1500NT-001	Scientific Wire Company
L4	22 nH Inductor	1212VS-22NMEB	Coilcraft
Q1	RF Power LDMOS Transistor	MRF1K50N	NXP
R1	10 Ω , 1/4 W Chip Resistor	CRCW120610R0JNEA	Vishay
R2, R3	33 Ω , 2 W Chip Resistors	1-2176070-3	TE Connectivity
PCB	Arlon TC350 0.030", $\epsilon_r = 3.5$	D87696	MTL

Note: Refer to MRF1K50N's [printed circuit boards and schematics](#) to download the 87.5–108 MHz heatsink drawing.

**TYPICAL CHARACTERISTICS — 87.5–108 MHz
BROADBAND REFERENCE CIRCUIT**

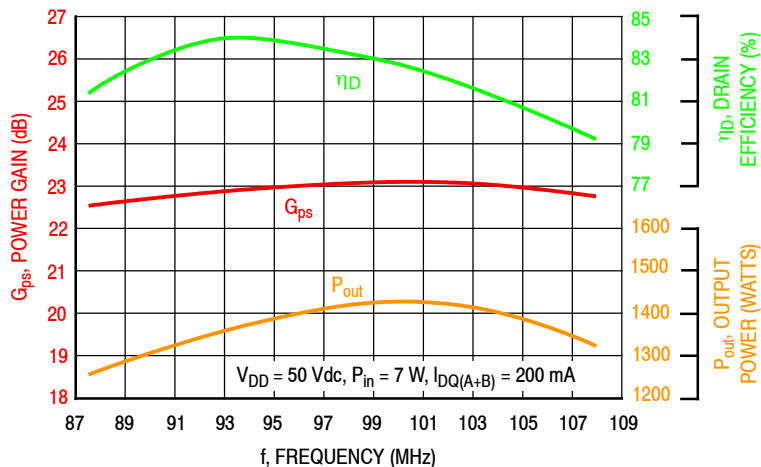


Figure 7. Power Gain, Drain Efficiency and CW Output Power versus Frequency at a Constant Input Power

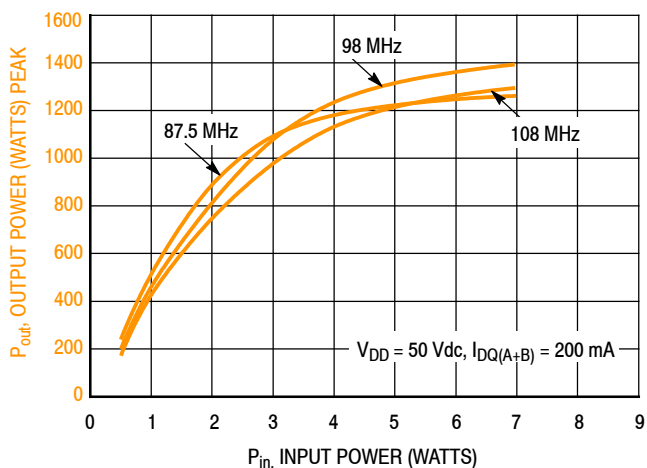


Figure 8. CW Output Power versus Input Power and Frequency

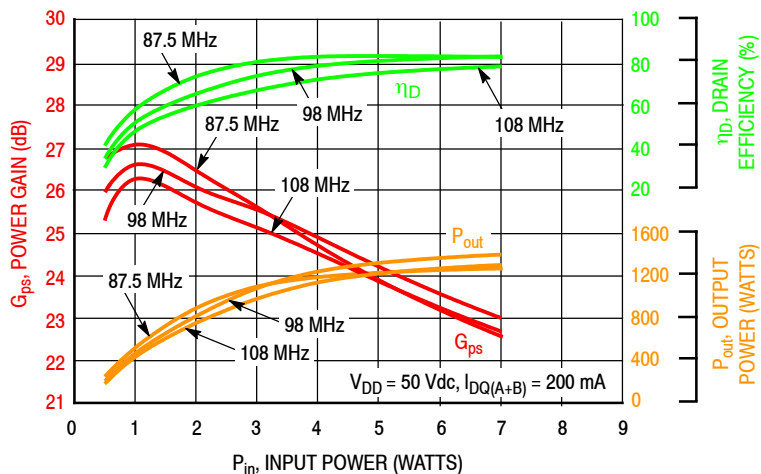
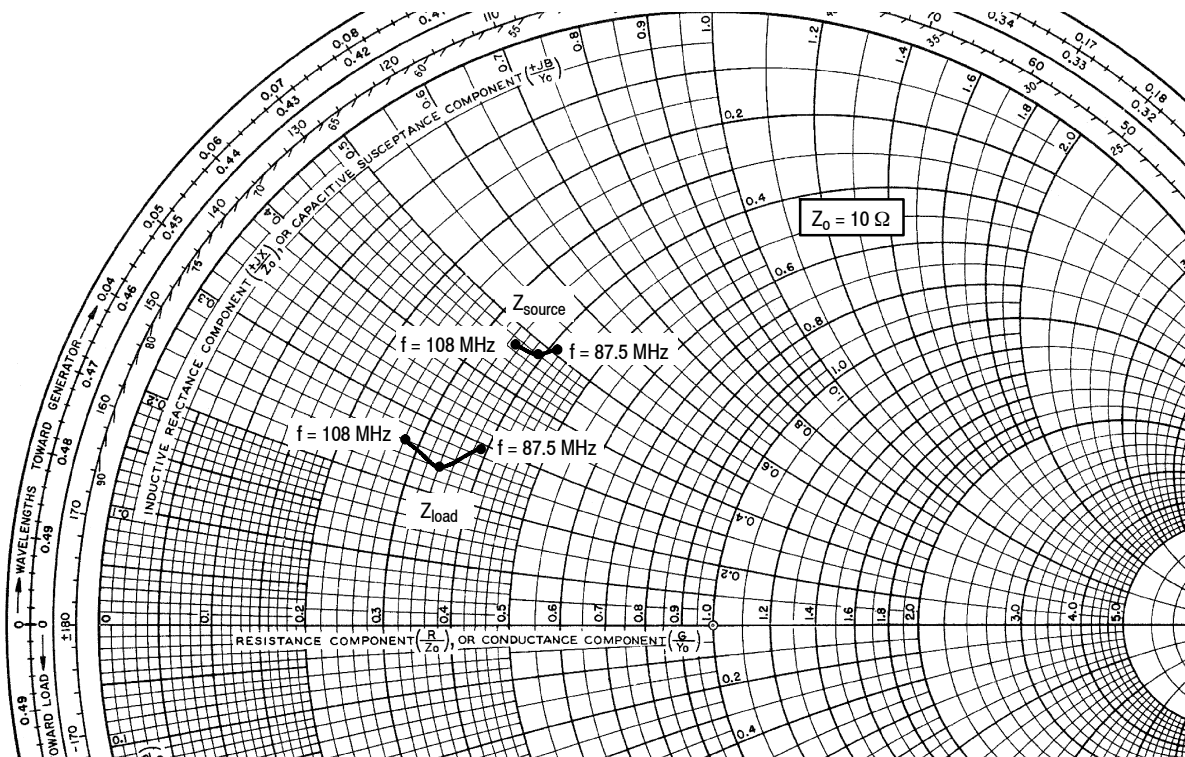


Figure 9. Power Gain, Drain Efficiency and CW Output Power versus Input Power and Frequency

87.5–108 MHz BROADBAND REFERENCE CIRCUIT



f MHz	Z _{source} Ω	Z _{load} Ω
87.5	4.07 + j5.13	3.92 + j2.89
98	3.93 + j4.84	3.39 + j2.35
108	3.50 + j4.72	2.83 + j2.56

Z_{source} = Test circuit impedance as measured from gate to gate, balanced configuration.

Z_{load} = Test circuit impedance as measured from drain to drain, balanced configuration.

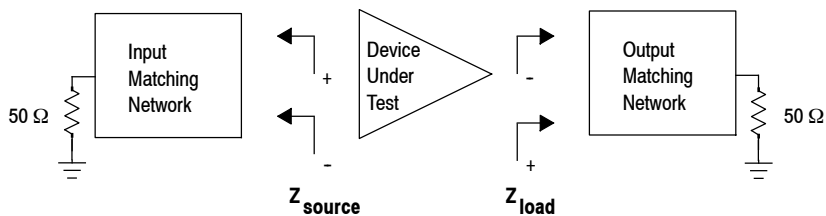
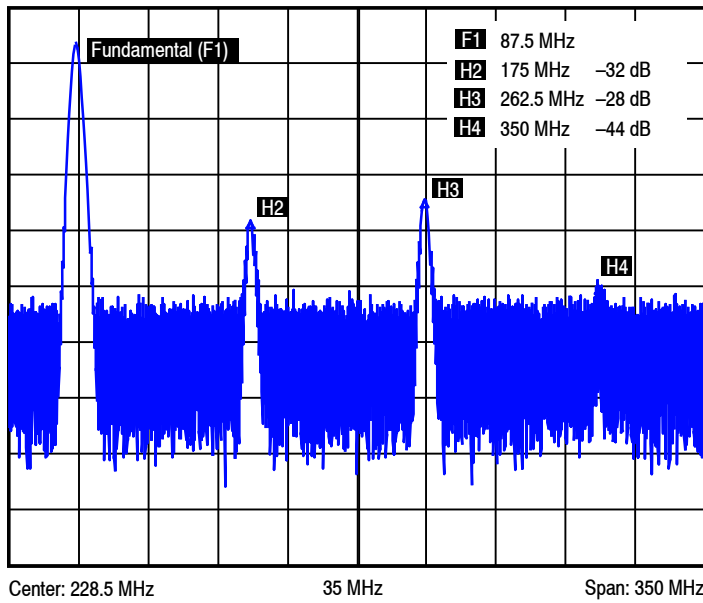


Figure 10. Broadband Series Equivalent Source and Load Impedance — 87.5–108 MHz

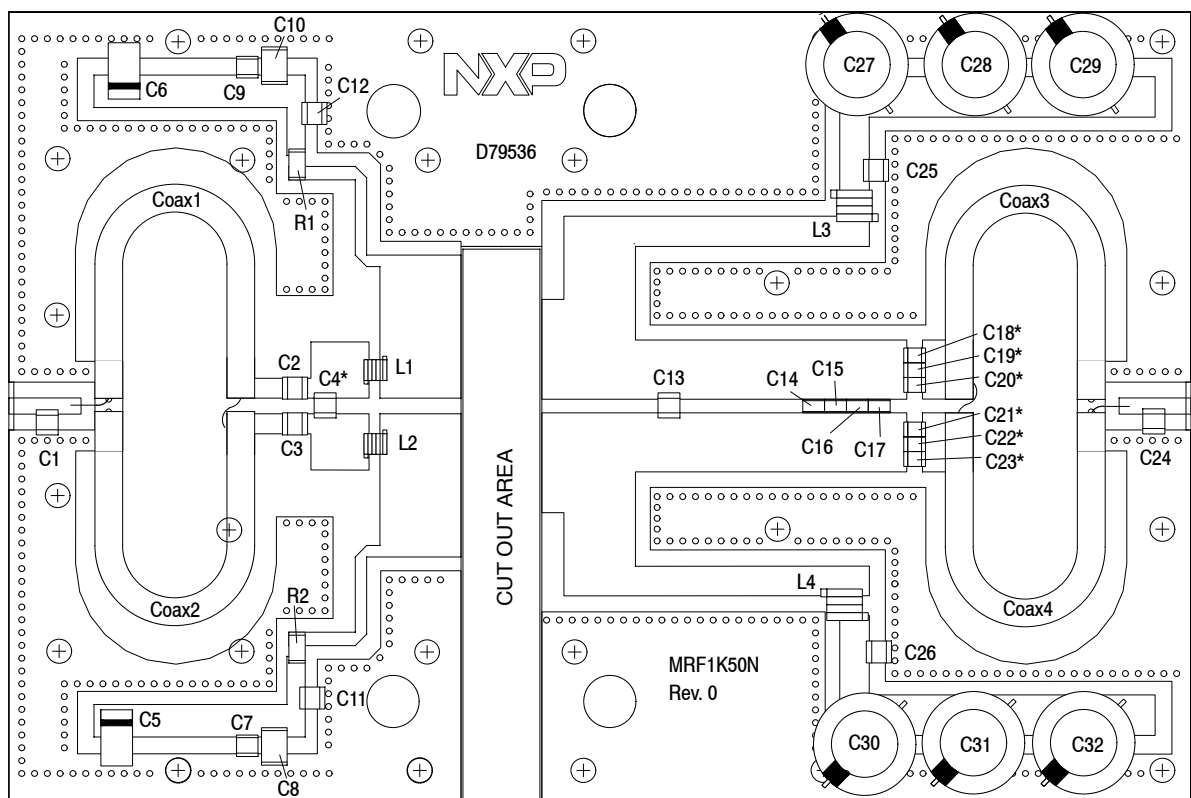
**HARMONIC MEASUREMENTS — 87.5–108 MHz
BROADBAND REFERENCE CIRCUIT**



H2 (175 MHz)	H3 (262.5 MHz)	H4 (350 MHz)
-32 dB	-28 dB	-44 dB

Figure 11. 87.5 MHz Harmonics @ 1200 W CW

230 MHz NARROWBAND PRODUCTION TEST FIXTURE — 6.0" x 4.0" (152 mm x 102 mm)



*C4, C18, C19, C20, C21, C22 and C23 are mounted vertically.

Figure 12. MRF1K50N Narrowband Test Circuit Component Layout — 230 MHz

Table 10. MRF1K50N Narrowband Test Circuit Component Designations and Values — 230 MHz

Part	Description	Part Number	Manufacturer
C1, C2, C3	22 pF Chip Capacitors	ATC100B220JT500XT	ATC
C4	27 pF Chip Capacitor	ATC100B270JT500XT	ATC
C5, C6	22 μF, 35 V Tantalum Capacitors	T491X226K035AT	Kemet
C7, C9	0.1 μF Chip Capacitors	CDR33BX104AKWS	AVX
C8, C10	220 nF Chip Capacitors	C1812C224K5RACTU	Kemet
C11, C12, C25, C26	1000 pF Chip Capacitors	ATC100B102JT50XT	ATC
C13	51 pF Chip Capacitor	ATC100B510JT500XT	ATC
C14	24 pF Chip Capacitor	ATC800R240JT500XT	ATC
C15, C16, C17	20 pF Chip Capacitors	ATC800R200JT500XT	ATC
C18, C19, C20, C21, C22, C23	240 pF Chip Capacitors	ATC100B241JT200XT	ATC
C24	8.2 pF Chip Capacitor	ATC100B8R2CT500XT	ATC
C27, C28, C29, C30, C31, C32	470 μF, 63 V Electrolytic Capacitors	MCGPR63V477M13X26-RH	Multicomp
Coax1, 2, 3, 4	25 Ω Semi Rigid Coax Cables, 2.2" Shield Length	UT-141C-25	Micro-Coax
L1, L2	5 nH Inductors	A02TKLC	Coilcraft
L3, L4	6.6 nH Inductors	GA3093-ALC	Coilcraft
R1, R2	10 Ω, 1/4 W Chip Resistors	CRCW120610R0JNEA	Vishay
PCB	Arlon AD255A 0.030", ε _r = 2.55	D79536	MTL

TYPICAL CHARACTERISTICS — 230 MHz PRODUCTION TEST FIXTURE

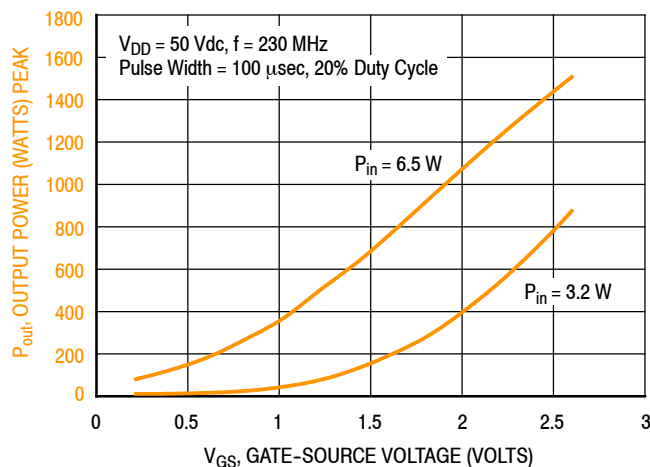
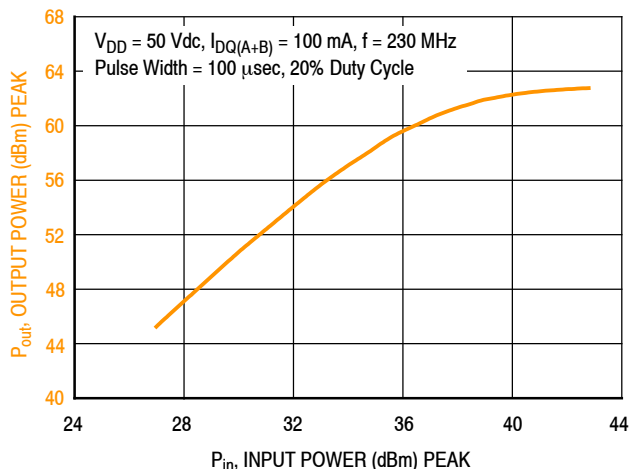


Figure 13. Output Power versus Gate-Source Voltage at a Constant Input Power



f (MHz)	P1dB (W)	P3dB (W)
230	1629	1857

Figure 14. Output Power versus Input Power

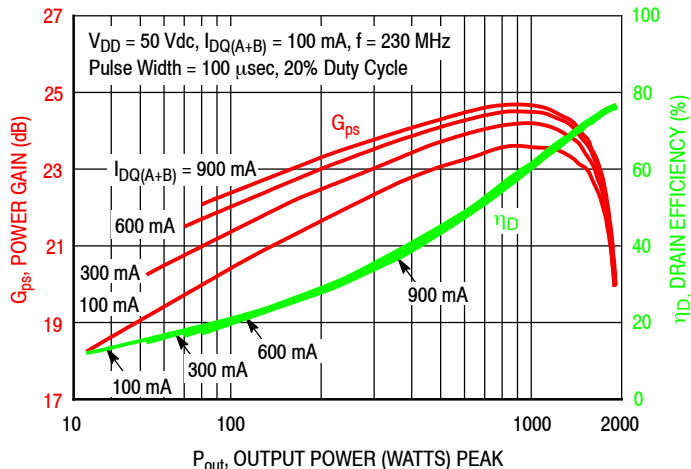


Figure 15. Power Gain and Drain Efficiency versus Output Power and Quiescent Current

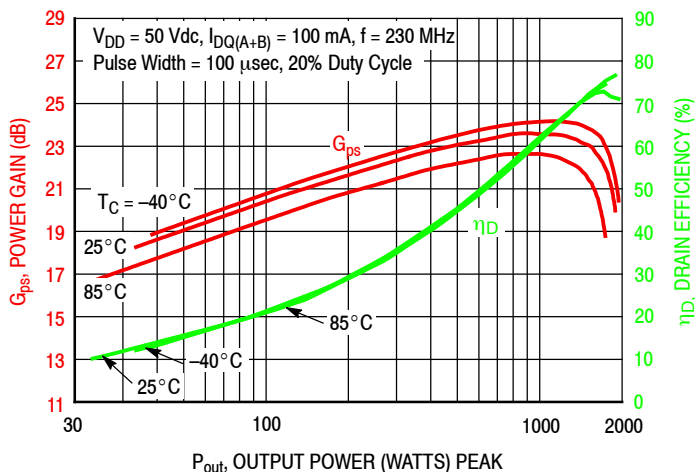


Figure 16. Power Gain and Drain Efficiency versus Output Power

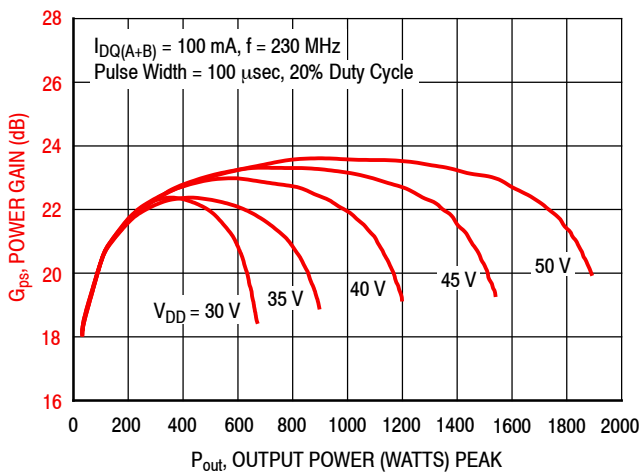


Figure 17. Power Gain versus Output Power and Drain-Source Voltage

230 MHz NARROWBAND PRODUCTION TEST FIXTURE

f MHz	Z_{source} Ω	Z_{load} Ω
230	$1.0 + j2.0$	$1.7 + j0.9$

Z_{source} = Test circuit impedance as measured from gate to gate, balanced configuration.

Z_{load} = Test circuit impedance as measured from drain to drain, balanced configuration.

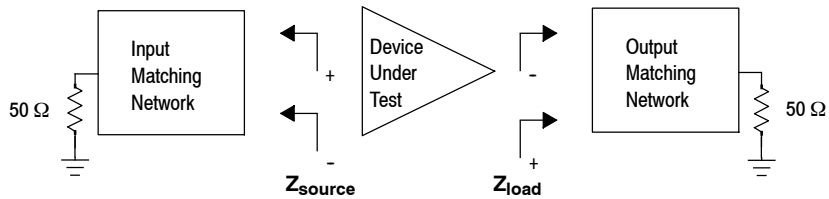
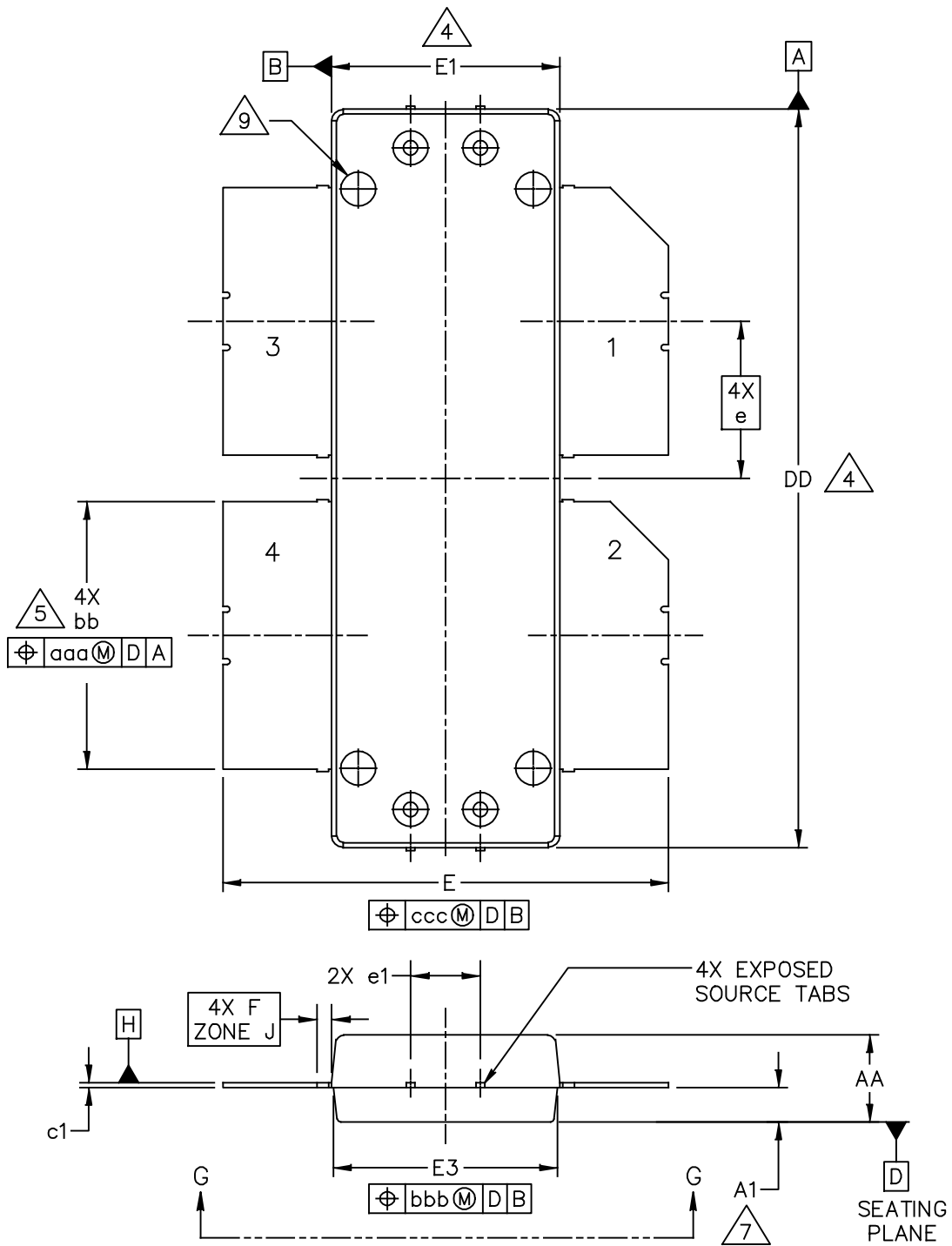
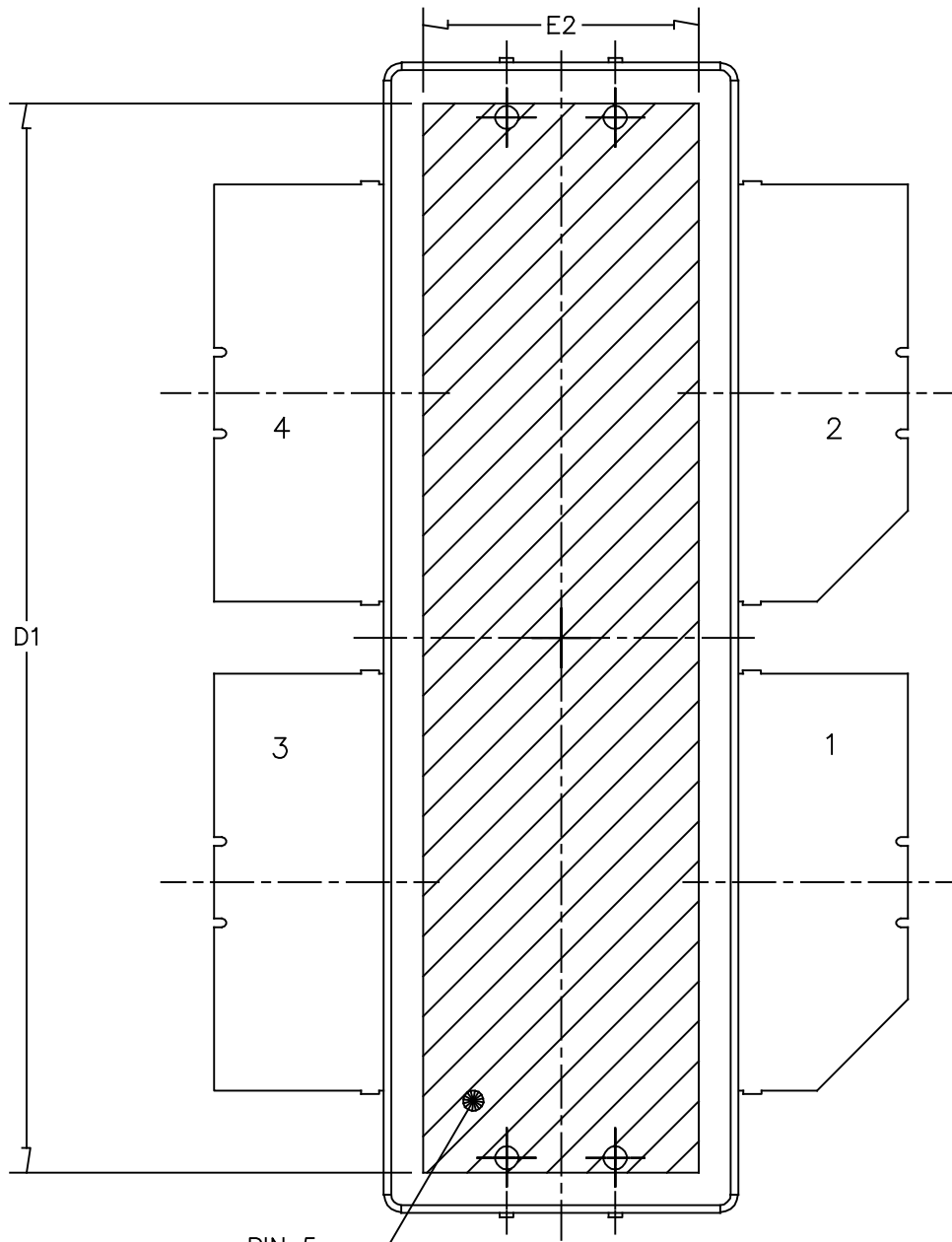


Figure 18. Narrowband Series Equivalent Source and Load Impedance — 230 MHz

PACKAGE DIMENSIONS



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TITLE: OM-1230-4L	DOCUMENT NO: 98ASA00506D	REV: C
	STANDARD: NON-JEDEC	
	SOT1816-1	08 FEB 2016



PIN 5

BOTTOM VIEW
 VIEW G-G

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TITLE: OM-1230-4L		DOCUMENT NO: 98ASA00506D	REV: C
		STANDARD: NON-JEDEC	
		SOT1816-1	08 FEB 2016

MRF1K50N MRF1K50GN

NOTES:

1. CONTROLLING DIMENSION: INCH
2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
3. DATUM PLANE H IS LOCATED AT TOP OF LEAD AND IS COINCIDENT WITH THE LEAD WHERE THE LEAD EXITS THE PLASTIC BODY AT THE TOP OF THE PARTING LINE.
4. DIMENSIONS DD AND E1 DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS .006 INCH (0.15 MM) PER SIDE. DIMENSIONS DD AND E1 DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE H.
5. DIMENSION bb DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE .005 INCH (0.13 MM) TOTAL IN EXCESS OF THE bb DIMENSION AT MAXIMUM MATERIAL CONDITION.
6. DATUMS A AND B TO BE DETERMINED AT DATUM PLANE H.
7. DIMENSION A1 APPLIES WITHIN ZONE J ONLY.
8. HATCHING REPRESENTS THE EXPOSED AREA OF THE HEAT SLUG. THE DIMENSIONS D1 AND E2 REPRESENT THE VALUES BETWEEN THE TWO OPPOSITE POINTS ALONG THE EDGES OF EXPOSED AREA OF HEAT SLUG.
9. DIMPLED HOLE REPRESENTS INPUT SIDE.

DIM	INCH		MILLIMETER		DIM	INCH		MILLIMETER	
	MIN	MAX	MIN	MAX		MIN	MAX	MIN	MAX
AA	.148	.152	3.76	3.86	bb	.457	.463	11.61	11.76
A1	.059	.065	1.50	1.65	c1	.007	.011	0.18	0.28
DD	1.267	1.273	32.18	32.33	e	.270 BSC		6.86 BSC	
D1	1.180	----	29.97	----	e1	.116	.124	2.95	3.15
E	.762	.770	19.35	19.56					
E1	.390	.394	9.91	10.01	aaa	.004		0.10	
E2	.306	----	7.77	----	bbb	.006		0.15	
E3	.383	.387	9.73	9.83	ccc	.010		0.25	
F	.025 BSC		0.635 BSC						
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TITLE: OM-1230-4L					DOCUMENT NO: 98ASA00506D REV: C				
					STANDARD: NON-JEDEC				
					SOT1816-1			08 FEB 2016	



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	STANDARD: NON-JEDEC		
	SOT1824-1	18 FEB 2016	



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TITLE: OM-1230G-4L	DOCUMENT NO: 98ASA00818D	REV: B
	STANDARD: NON-JEDEC	
	SOT1824-1	18 FEB 2016

NOTES:

1. CONTROLLING DIMENSION: INCH
2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
3. DATUM PLANE H IS LOCATED AT TOP OF LEAD AND IS COINCIDENT WITH THE LEAD WHERE THE LEAD EXITS THE PLASTIC BODY AT THE TOP OF THE PARTING LINE.
4. DIMENSIONS DD AND E1 DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS .006 INCH (0.15 MM) PER SIDE. DIMENSIONS DD AND E1 DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE H.
5. DIMENSION bb DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE .005 INCH (0.13 MM) TOTAL IN EXCESS OF THE bb DIMENSION AT MAXIMUM MATERIAL CONDITION.
6. DATUMS A AND B TO BE DETERMINED AT DATUM PLANE H.
7. HATCHING REPRESENTS THE EXPOSED AND SOLDERABLE AREA OF THE HEAT SLUG. THE DIMENSIONS D1 AND E2 REPRESENT THE VALUES BETWEEN THE TWO OPPOSITE POINTS ALONG THE EDGES OF EXPOSED AREA OF HEAT SLUG.
8. DIMPLED HOLE REPRESENTS INPUT SIDE.
9. DIMENSION A1 IS MEASURED WITH REFERENCE TO DATUM D. THE POSITIVE VALUE IMPLIES THAT THE BOTTOM OF THE PACKAGE IS HIGHER THAN THE BOTTOM OF THE LEAD.

DIM	INCH		MILLIMETER		DIM	INCH		MILLIMETER	
	MIN	MAX	MIN	MAX		MIN	MAX	MIN	MAX
AA	.148	.152	3.76	3.86	bb	.457	.463	11.61	11.76
A1	-.003	.003	-0.08	0.08	c1	.007	.011	0.18	0.28
DD	1.267	1.273	32.18	32.33	e	.270 BSC		6.86 BSC	
D1	1.180	----	29.97	----	e1	.116	.124	2.95	3.15
E	.563	.575	14.30	14.61	θ	0°	8°	0°	8°
E1	.390	.394	9.91	10.01	aaa	.004		0.10	
E2	.306	----	7.77	----	bbb	.006		0.15	
E3	.383	.387	9.73	9.83	ccc	.010		0.25	
L	.034	.046	0.86	1.17					
L1	.010 BSC		0.25 BSC						

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PRODUCT DOCUMENTATION, SOFTWARE AND TOOLS

Refer to the following resources to aid your design process.

Application Notes

- AN1907: Solder Reflow Attach Method for High Power RF Devices in Over-Molded Plastic Packages
- AN1955: Thermal Measurement Methodology of RF Power Amplifiers

Engineering Bulletins

- EB212: Using Data Sheet Impedances for RF LDMOS Devices

Software

- Electromigration MTTF Calculator
- RF High Power Model
- .s2p File

Development Tools

- Printed Circuit Boards

To Download Resources Specific to a Given Part Number:

1. Go to <http://www.nxp.com/RF>
2. Search by part number
3. Click part number link
4. Choose the desired resource from the drop down menu

REVISION HISTORY

The following table summarizes revisions to this document.

Revision	Date	Description
0	Nov. 2016	• Initial Release of Data Sheet

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Телефон: 8 (812) 309-75-97 (многоканальный)

Факс: 8 (812) 320-03-32

Электронная почта: ocean@oceanchips.ru

Web: <http://oceanchips.ru/>

Адрес: 198099, г. Санкт-Петербург, ул. Калинина, д. 2, корп. 4, лит. А